## Notice of References Cited Application/Control No. 10/771,091 Examiner Sikha Roy Applicant(s)/Patent Under Reexamination LEE ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,737,800	05-2004	Winters et al.	313/504
*	В	US-5,554,911	09-1996	Nakayama et al.	313/504
*	С	US-6,639,250	10-2003	Shimoda et al.	257/98
*	D	US-6,853,132	02-2005	Maeda, Tsuyoshi	313/504
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	_	US-			
	7	US-			
	K	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν	JP 10308285 A	11-1998	Japan	TAKAHATA et al.	
	0	GB 2349979 A	11-2000	United Kingdom	BURROUGHES et al.	
	Ρ					
	Q					
	R.					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	>	
	w	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.